

10/573544

10/573544 27 MAR 2006

Docket No.: 2003P13008

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Henryk Frenzel, et al.
Filed : Concurrently herewith
Title : Optical Module Comprising an Image Sensor and a Lens Unit That is
Supported on the Sensitive Surface of the Image Sensor

INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner for Patents
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.97(b)(1), copies of the following patents and/or publications are herewith cited to the Office:

International Publication WO 03/105465 A1 (Dirmeyer, et al.), dated December 18, 2003;

Japanese Patent JP 2002-341218 (Yamaguchi, et al.), dated November 27, 2002, and English abstract thereof;

Japanese Patent JP 2002-16826 (Nakayama), dated January 18, 2002, and English abstract thereof;

International Search Report, dated January 14, 2005.

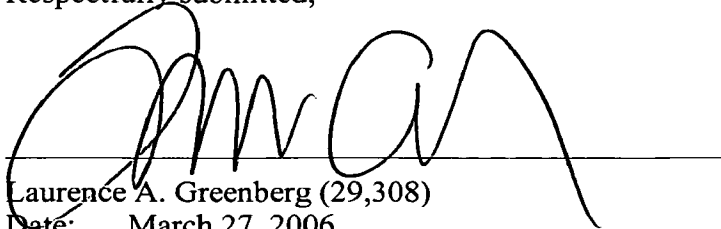
ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /E.R./

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IAP6 Rec'd PCT/PTO 27 MAR 2006

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant.

Respectfully submitted,

A handwritten signature in black ink, appearing to read 'LAURENCE A. GREENBERG', is written over a horizontal line.

Laurence A. Greenberg (29,308)

Date: March 27, 2006

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FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.97(b)(1))				Attorney Docket No.: 2003P13008 Applic. No. Concurrently herewith Applicant Henryk Frenzel, et al. Filing Date Group Art Unit March 27, 2006			
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EXAMINER INITIALS	PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A					
	B					
	C					
	D					
	E					
	F					
	G					
	H					
	I					

FOREIGN PATENT DOCUMENT							
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO	
	J	WO 03/105465 A1	12/2003	WIPO			
	K	JP 2002-341218	11/2002	Japan			
	L	JP 2002-16826	1/2002	Japan			
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)		

EXAMINER /Eduardo Rodela/	DATE CONSIDERED 07/28/2008
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.